

$V_{DM}$	=	4200 V
$I_{T(AV)M}$	=	1920 A
$I_{T(RMS)}$	=	3020 A
$I_{TSM}$	=	$32 \times 10^3$ A
$V_{T0}$	=	0.96 V
$r_T$	=	0.285 mW

# Bi-Directional Control Thyristor

## 5STB 18N4200

Doc. No. 5SYA1040-04 May 07

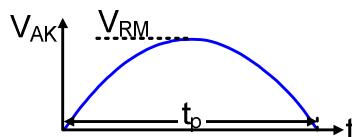
- Two thyristors integrated into one wafer
- Patented free-floating silicon technology
- Designed for energy management and industrial applications
- Optimum power handling capability
- Interdigitated amplifying gate

The electrical and thermal data are valid for one-thyristor-half of the device (unless otherwise stated)

### Blocking

*Maximum rated values<sup>1)</sup>*

Parameter	Symbol	Conditions	5STB 18N4200	Unit
Max repetitive peak forward blocking voltage	$V_{RM}$	$f = 50$ Hz, $t_p = 10$ ms, $T_{vj} = 5 \dots 125^\circ\text{C}$ , Note 1	4200	V
Critical rate of rise of off-state voltage	$dv/dt_{crit}$	Exp. to 2810 V, $T_{vj} = 125^\circ\text{C}$	1000	V/ $\mu$ s



*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Max reverse leakage current	$I_{RM}$	$V_{RM}$ , $T_{vj} = 125^\circ\text{C}$			400	mA

Note 1: Voltage de-rating factor of 0.11% per  $^\circ\text{C}$  is applicable for  $T_{vj}$  below  $+5^\circ\text{C}$

### Mechanical data

*Maximum rated values<sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Mounting force	$F_M$		81	90	108	kN
Acceleration	a	Device unclamped			50	$\text{m/s}^2$
Acceleration	a	Device clamped			100	$\text{m/s}^2$

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Weight	m				2.9	kg
Housing thickness	H	$F_M = 90$ kN, $T_a = 25^\circ\text{C}$	34.6		35.2	mm
Surface creepage distance	$D_S$		53			mm
Air strike distance	$D_a$		22			mm

1) Maximum rated values indicate limits beyond which damage to the device may occur

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## On-state

*Maximum rated values<sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Average on-state current	$I_{T(AV)M}$	Half sine wave, $T_c = 70^\circ C$			1920	A
RMS on-state current	$I_{T(RMS)}$				3020	A
RMS on-state current	$I_{T(RMS)}$	$t_p = 10 \text{ ms}, T_{vj} = 125^\circ C$ , sine wave after surge: $V_D = V_R = 0 \text{ V}$			4265	A
Peak non-repetitive surge current	$I_{TSM}$				$32.0 \times 10^3$	A
Limiting load integral	$I^2t$	$t_p = 8.3 \text{ ms}, T_{vj} = 125^\circ C$ , sine wave after surge: $V_D = V_R = 0 \text{ V}$			$5.12 \times 10^6$	$\text{A}^2\text{s}$
Peak non-repetitive surge current	$I_{TSM}$				$35.0 \times 10^3$	A
Limiting load integral	$I^2t$				$5.00 \times 10^6$	$\text{A}^2\text{s}$

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
On-state voltage	$V_T$	$I_T = 2000 \text{ A}, T_{vj} = 125^\circ C$			1.53	V
Threshold voltage	$V_{TO}$	$I_T = 1000 \text{ A} - 3000 \text{ A}, T_{vj} = 125^\circ C$			0.96	V
Slope resistance	$r_T$				0.285	$\text{m}\Omega$
Holding current	$I_H$	$T_{vj} = 25^\circ C$			250	mA
		$T_{vj} = 125^\circ C$			150	mA
Latching current	$I_L$	$T_{vj} = 25^\circ C$			500	mA
		$T_{vj} = 125^\circ C$			300	mA

## Switching

*Maximum rated values<sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Critical rate of rise of on-state current	$di/dt_{crit}$	$T_{vj} = 125^\circ C, I_{TRM} = 3000 \text{ A}, f = 50 \text{ Hz}$			250	$\text{A}/\mu\text{s}$
Critical rate of rise of on-state current	$di/dt_{crit}$				500	$\text{A}/\mu\text{s}$
Circuit commutated turn-off time	$t_q$	$T_{vj} = 125^\circ C, I_{TRM} = 2000 \text{ A}, V_R = 200 \text{ V}, di_T/dt = -1.5 \text{ A}/\mu\text{s}, V_D \leq 0.67 \cdot V_{RM}, dv_D/dt = 20 \text{ V}/\mu\text{s}$	550			$\mu\text{s}$
Critical rate of rise of commutating voltage	$dv/dt_{com}$	$T_{vj} = 125^\circ C, V_R \leq 0.67 \cdot V_{RM}$			500	$\text{V}/\mu\text{s}$

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Reverse recovery charge	$Q_{rr}$	$T_{vj} = 125^\circ C, I_{TRM} = 2000 \text{ A}, V_R = 200 \text{ V}, di_T/dt = -1.5 \text{ A}/\mu\text{s}$	1500		3200	$\mu\text{As}$
Reverse recovery current	$I_{RM}$		40		70	A
Gate turn-on delay time	$t_{gd}$	$T_{vj} = 25^\circ C, V_D = 0.4 \cdot V_{RM}, I_{FG} = 2 \text{ A}, t_r = 0.5 \mu\text{s}$			3	$\mu\text{s}$

## Triggering

*Maximum rated values<sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Peak forward gate voltage	V <sub>FGM</sub>				12	V
Max. rated peak forward gate current	I <sub>FGM</sub>				10	A
Peak reverse gate voltage	V <sub>RGM</sub>				10	V
Max. rated gate power loss	P <sub>G</sub>	For DC gate current			3	W
Max. rated peak forward gate power	P <sub>GM(AV)</sub>			see Fig. 9		W

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Gate trigger voltage	V <sub>GT</sub>	T <sub>vj</sub> = 25 °C			2.6	V
Gate trigger current	I <sub>GT</sub>	T <sub>vj</sub> = 25 °C			400	mA
Gate non-trigger voltage	V <sub>GD</sub>	V <sub>D</sub> = 0.4 x V <sub>RM</sub> , T <sub>vj</sub> = 125 °C	0.3			V
Gate non-trigger current	I <sub>GD</sub>	V <sub>D</sub> = 0.4 x V <sub>RM</sub>	10			mA

## Thermal

*Maximum rated values<sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Operating junction temperature range	T <sub>vj</sub>				125	°C
Storage temperature range	T <sub>stg</sub>		-40		140	°C

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Thermal resistance junction to case (Valid for one thyristor half no heat flow to the second half.)	R <sub>th(j-c)</sub>	Double-side cooled F <sub>m</sub> = 81...108 kN			11.4	K/kW
	R <sub>th(j-c)</sub>	Single-side cooled F <sub>m</sub> = 81...108 kN			22.8	K/kW
Thermal resistance case to heatsink	R <sub>th(c-h)</sub>	Double-side cooled F <sub>m</sub> = 81...108 kN			2	K/kW
	R <sub>th(c-h)</sub>	Single-side cooled F <sub>m</sub> = 81...108 kN			4	K/kW

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/t_i})$$

i	1	2	3	4
R <sub>i</sub> (K/kW)	7.434	2.535	0.948	0.485
t <sub>i</sub> (s)	0.8651	0.1105	0.0116	0.0024

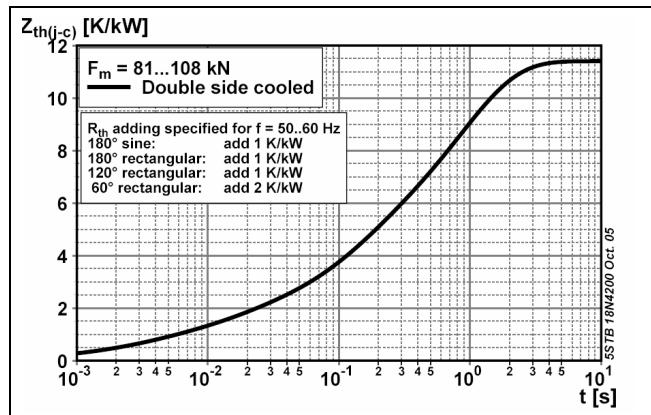


Fig. 1 Transient thermal impedance (junction-to-case) vs. time

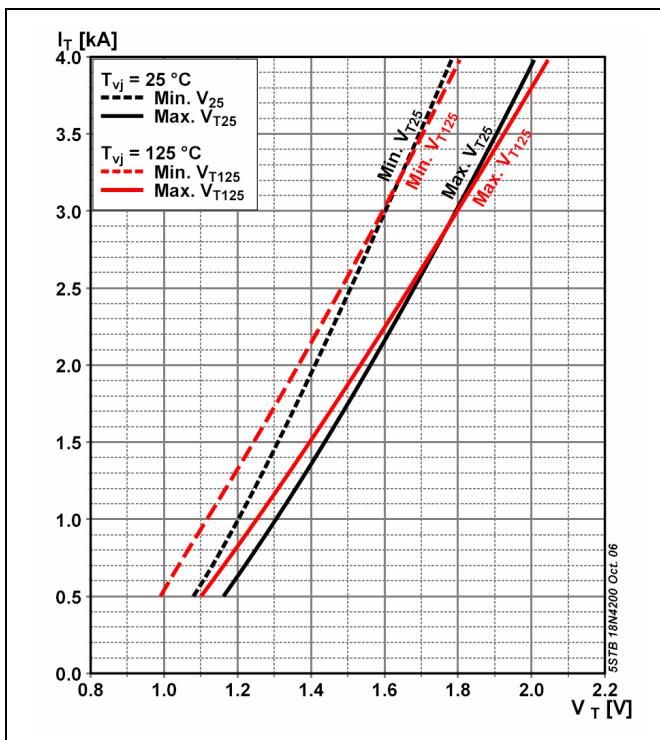


Fig. 2 On-state voltage characteristics

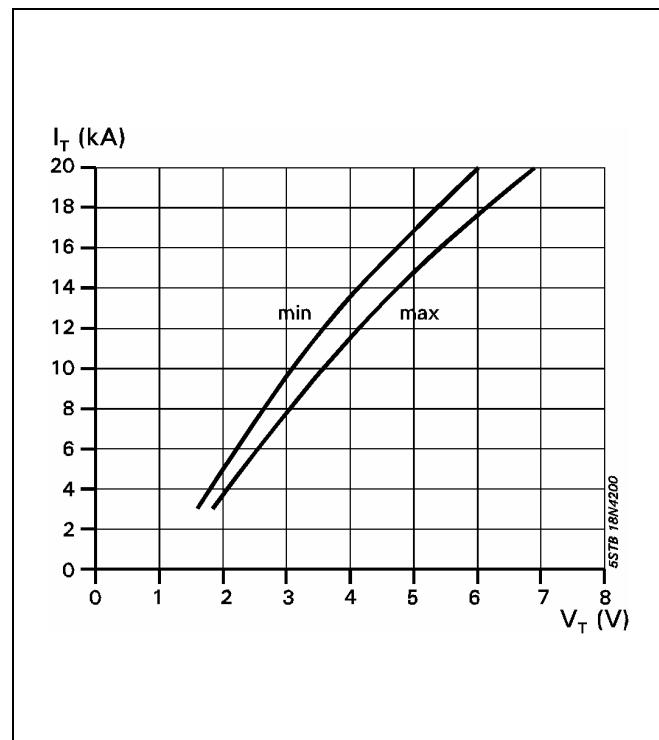
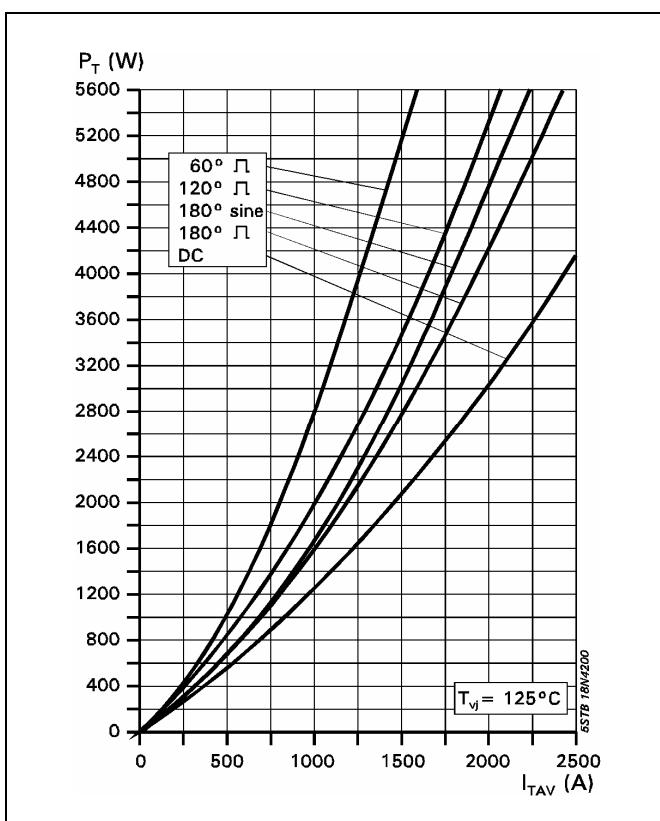
Fig. 3 On-state characteristics.  
 $T_j = 125^\circ\text{C}$ , 10ms half sine.

Fig. 4 On-state power dissipation vs. mean on-state current. Turn-on losses excluded.

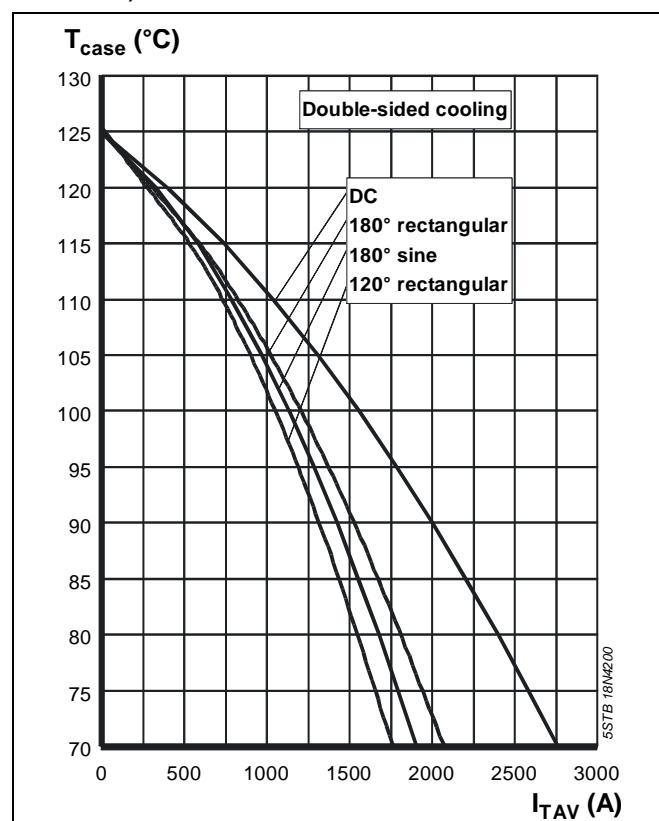
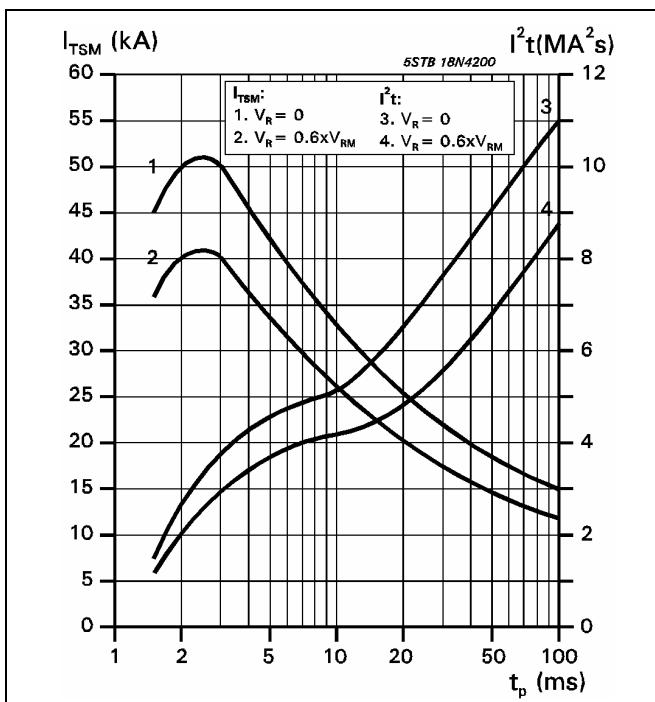
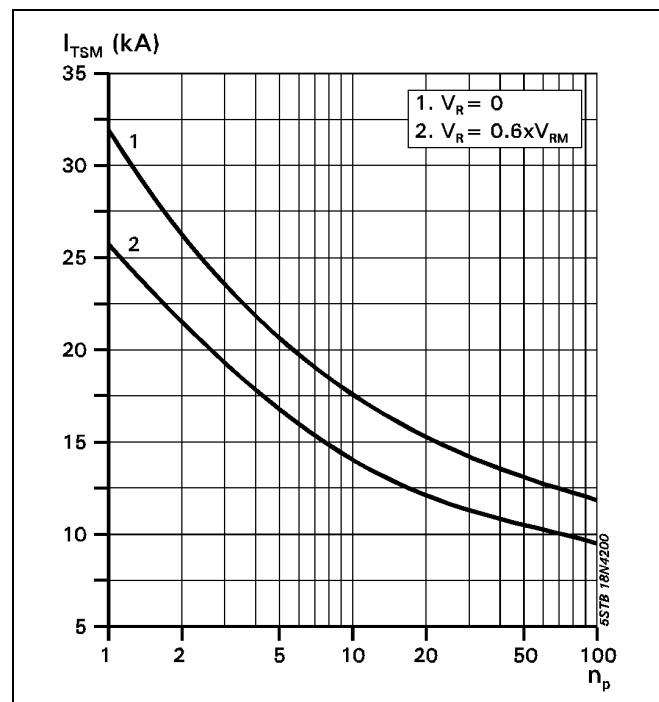


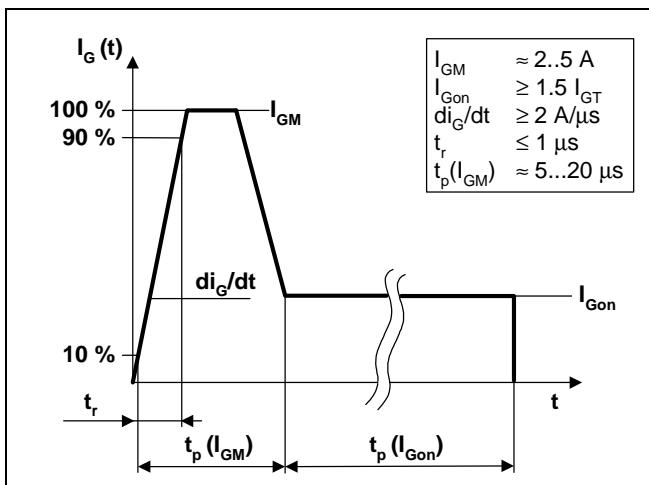
Fig. 5 Max. permissible case temperature vs. mean on-state current. Switching losses ignored.



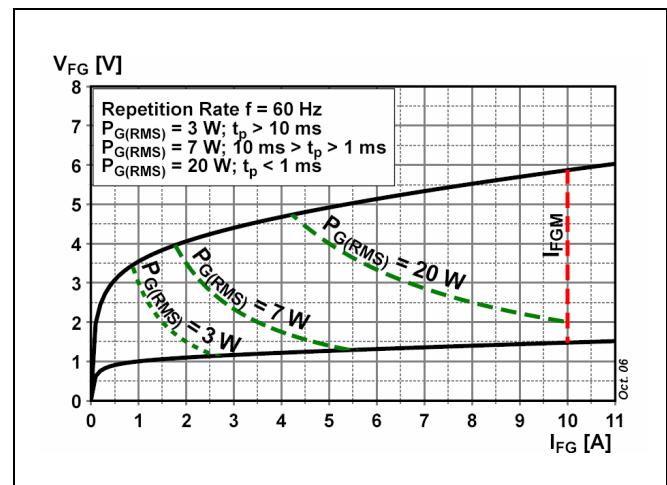
**Fig. 6** Surge on-state current vs. pulse length.  
Half-sine wave.



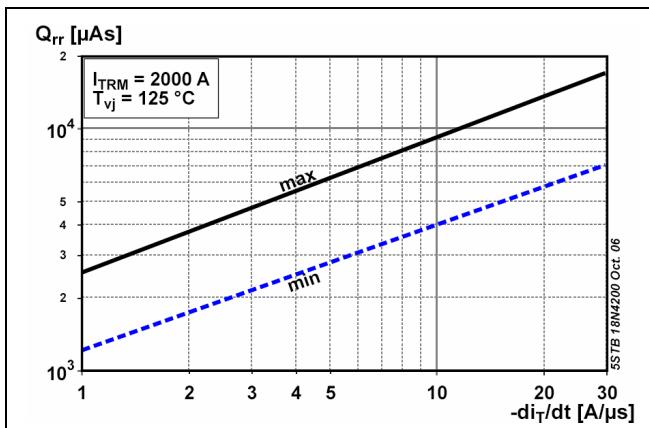
**Fig. 7** Surge on-state current vs. number of pulses.  
Half-sine wave, 10 ms, 50Hz.



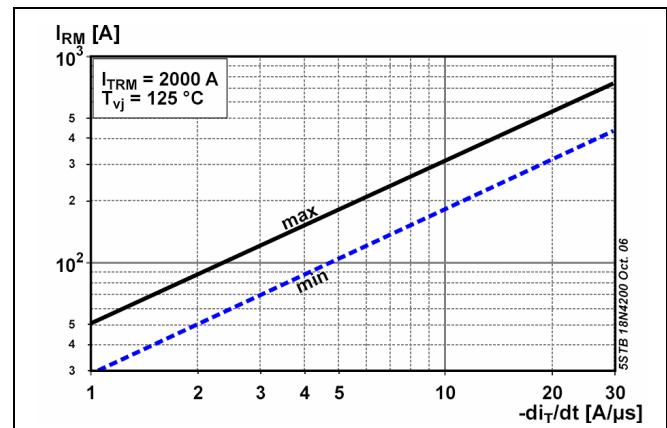
**Fig. 8** Recommended gate current waveform



**Fig. 9** Max. peak gate power loss



**Fig. 10** Reverse recovery charge vs. decay rate of on-state current



**Fig. 11** Peak reverse recovery current vs. decay rate of on-state current

## Turn-on and Turn-off losses

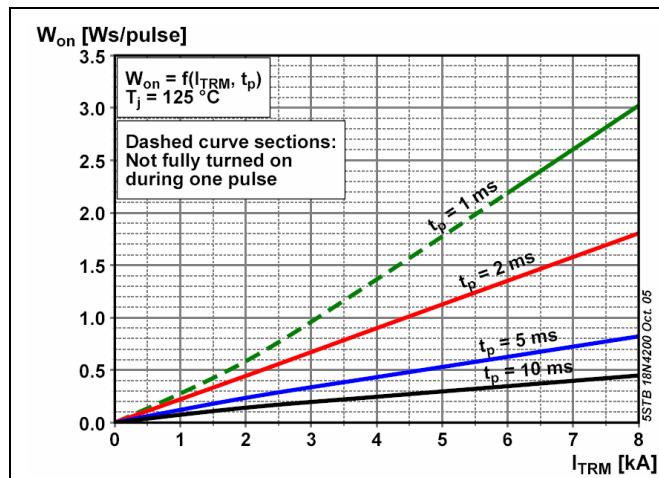


Fig. 12 Turn-on energy, half sinusoidal waves

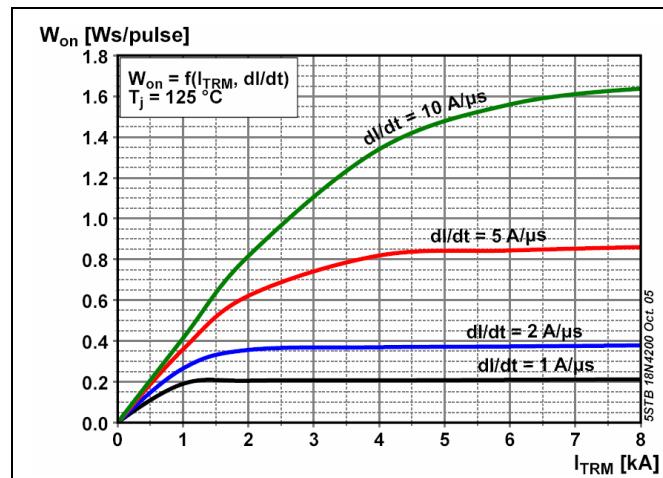


Fig. 13 Turn-on energy, rectangular waves

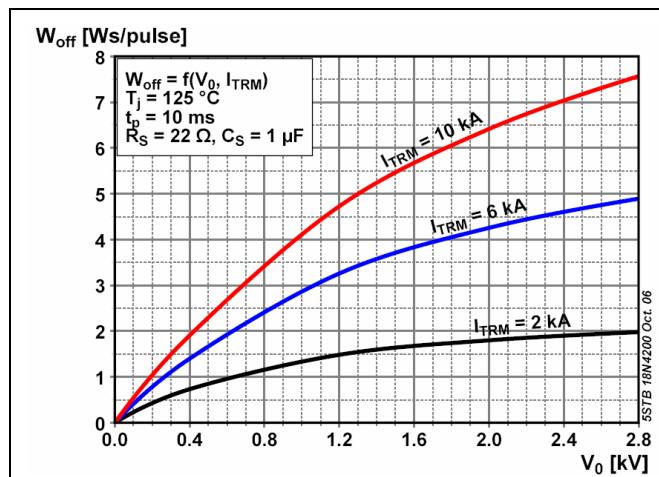


Fig. 14 Turn-off energy, half sinusoidal waves

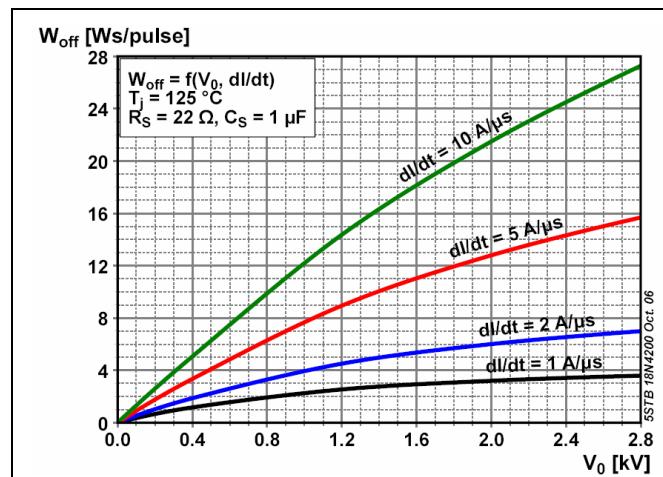


Fig. 15 Turn-off energy, rectangular waves

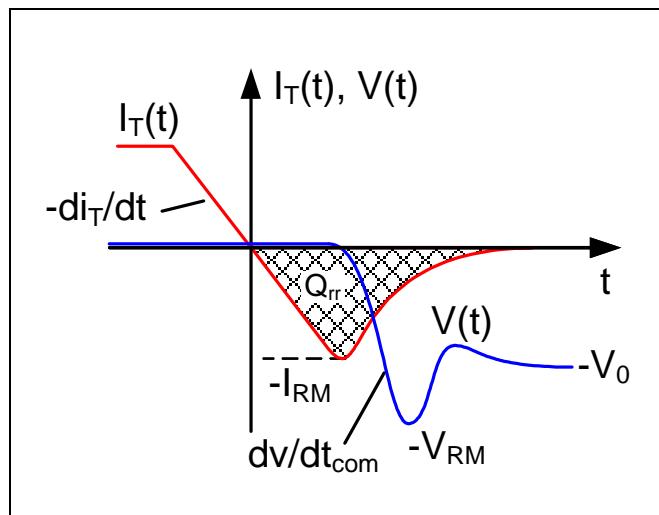


Fig. 16 Current and voltage waveforms at turn-off

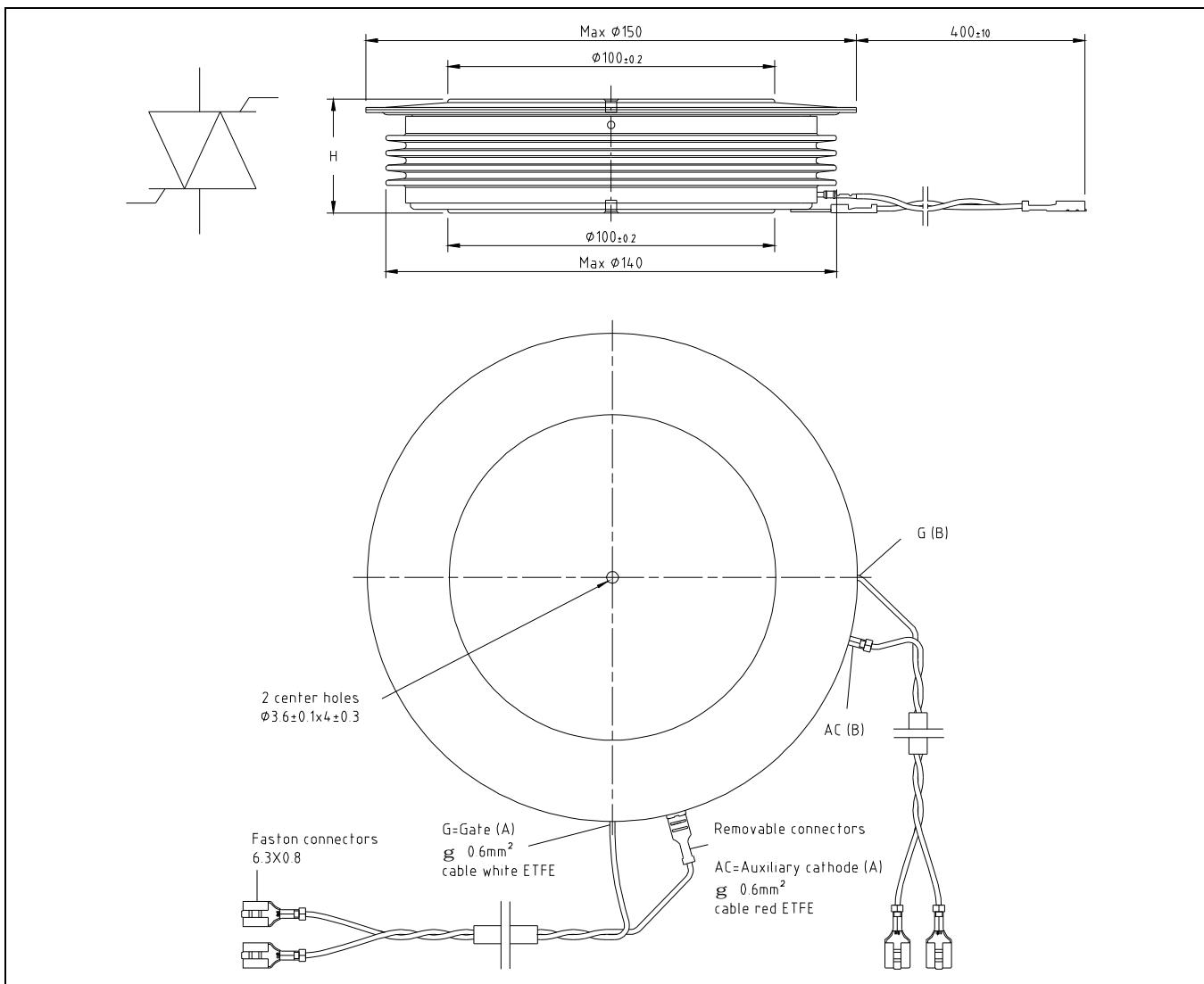
### Total power loss for repetitive waveforms:

$$P_{TOT} = P_T + W_{on} \cdot f + W_{off} \cdot f$$

where

$$P_T = \frac{1}{T} \int_0^T I_T \cdot V_T(I_T) dt$$

Fig. 17 Relationships for power loss



**Fig. 18** Device Outline Drawing

### Related documents:

- 
- |           |   |
|-----------|---|
| 5SYA 2020 | Design of RC-Snubber for Phase Control Applications   |
| 5SYA 2049 | Voltage definitions for phase control thyristors and diodes   |
| 5SYA 2051 | Voltage ratings of high power semiconductors  |
| 5SYA 2034 | Gate-Drive Recommendations for PCT's  |
| 5SYA 2036 | Recommendations regarding mechanical clamping of Press Pack High Power Semiconductors   |
| 5SZK 9104 | Specification of environmental class for pressure contact diodes, PCTs and GTO, STORAGE available on request, please contact factory        |
| 5SZK 9105 | Specification of environmental class for pressure contact diodes, PCTs and GTO, TRANSPORTATION available on request, please contact factory |

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